

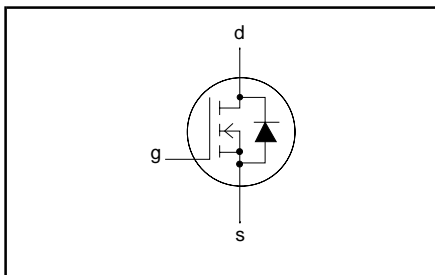
**PowerMOS transistors  
FREDFET, Avalanche energy rated**

**PHX6ND50E**

**FEATURES**

- Repetitive Avalanche Rated
- Fast switching
- Stable off-state characteristics
- High thermal cycling performance
- Isolated package
- Fast reverse recovery diode

**SYMBOL**



**QUICK REFERENCE DATA**

$V_{DSS} = 500\text{ V}$
$I_D = 3.1\text{ A}$
$R_{DS(ON)} \leq 1.5\ \Omega$
$t_{rr} = 180\text{ ns}$

**GENERAL DESCRIPTION**

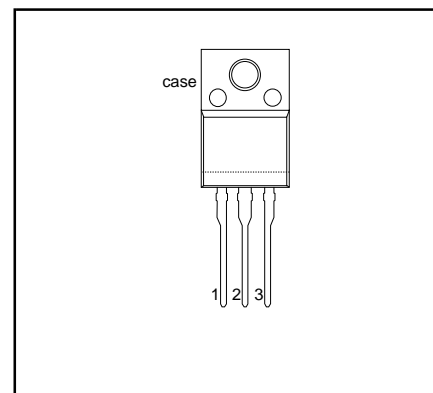
N-channel, enhancement mode field-effect power transistor, incorporating a Fast Recovery Epitaxial Diode (FRED). This gives improved switching performance in half bridge and full bridge converters making this device particularly suitable for inverters, lighting ballasts and motor control circuits.

The PHX6ND50E is supplied in the SOT186A full pack, isolated package.

**PINNING**

PIN	DESCRIPTION
1	gate
2	drain
3	source
case	isolated

**SOT186A**



**LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DSS}$	Drain-source voltage	$T_j = 25\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$	-	500	V
$V_{DGR}$	Drain-gate voltage	$T_j = 25\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$ ; $R_{GS} = 20\text{ k}\Omega$	-	500	V
$V_{GS}$	Gate-source voltage		-	$\pm 30$	V
$I_D$	Continuous drain current	$T_{hs} = 25\text{ }^\circ\text{C}$ ; $V_{GS} = 10\text{ V}$	-	3.1	A
$I_{DM}$	Pulsed drain current <sup>1</sup>	$T_{hs} = 100\text{ }^\circ\text{C}$ ; $V_{GS} = 10\text{ V}$	-	2	A
$P_D$	Total dissipation	$T_{hs} = 25\text{ }^\circ\text{C}$	-	24	A
$T_j, T_{stg}$	Operating junction and storage temperature range	$T_{hs} = 25\text{ }^\circ\text{C}$	-55	150	$^\circ\text{C}$

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### AVALANCHE ENERGY LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$E_{AS}$	Non-repetitive avalanche energy	Unclamped inductive load, $I_{AS} = 4$ A; $t_p = 0.17$ ms; $T_j$ prior to avalanche = 25°C; $V_{DD} \leq 50$ V; $R_{GS} = 50$ Ω; $V_{GS} = 10$ V; refer to fig:17	-	280	mJ
$E_{AR}$	Repetitive avalanche energy <sup>1</sup>	$I_{AR} = 5.9$ A; $t_p = 1$ μs; $T_j$ prior to avalanche = 25°C; $R_{GS} = 50$ Ω; $V_{GS} = 10$ V; refer to fig:18	-	10	mJ
$I_{AS}, I_{AR}$	Repetitive and non-repetitive avalanche current		-	5.9	A

### ISOLATION LIMITING VALUE & CHARACTERISTIC

 $T_{hs} = 25$  °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{isol}$	R.M.S. isolation voltage from all three terminals to external heatsink	$f = 50$ -60 Hz; sinusoidal waveform; R.H. $\leq 65\%$ ; clean and dustfree	-		2500	V
$C_{isol}$	Capacitance from T2 to external heatsink	$f = 1$ MHz	-	10	-	pF

### THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$R_{th\ j-hs}$	Thermal resistance junction to heatsink	with heatsink compound	-	-	3.6	K/W
$R_{th\ j-a}$	Thermal resistance junction to ambient		-	55	-	K/W

<sup>1</sup> pulse width and repetition rate limited by  $T_j$  max.

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### ELECTRICAL CHARACTERISTICS

$T_j = 25\text{ °C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}; I_D = 0.25\text{ mA}$	500	-	-	V
$\frac{\Delta V_{(BR)DSS}}{\Delta T_j}$	Drain-source breakdown voltage temperature coefficient	$V_{DS} = V_{GS}; I_D = 0.25\text{ mA}$	-	0.1	-	%/K
$R_{DS(ON)}$	Drain-source on resistance	$V_{GS} = 10\text{ V}; I_D = 3\text{ A}$	-	1.2	1.5	$\Omega$
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 0.25\text{ mA}$	2.0	3.0	4.0	V
$g_{fs}$	Forward transconductance	$V_{DS} = 30\text{ V}; I_D = 3\text{ A}$	2	3.6	-	S
$I_{DSS}$	Drain-source leakage current	$V_{DS} = 500\text{ V}; V_{GS} = 0\text{ V}$	-	1	25	$\mu\text{A}$
		$V_{DS} = 400\text{ V}; V_{GS} = 0\text{ V}; T_j = 125\text{ °C}$	-	30	250	$\mu\text{A}$
$I_{GSS}$	Gate-source leakage current	$V_{GS} = \pm 30\text{ V}; V_{DS} = 0\text{ V}$	-	10	200	nA
$Q_{g(tot)}$	Total gate charge	$I_D = 6\text{ A}; V_{DD} = 400\text{ V}; V_{GS} = 10\text{ V}$	-	53	64	nC
$Q_{gs}$	Gate-source charge		-	4	6	nC
$Q_{gd}$	Gate-drain (Miller) charge		-	28	34	nC
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 250\text{ V}; R_D = 39\text{ }\Omega;$	-	10	-	ns
$t_r$	Turn-on rise time	$R_G = 12\text{ }\Omega$	-	33	-	ns
$t_{d(off)}$	Turn-off delay time		-	92	-	ns
$t_f$	Turn-off fall time		-	40	-	ns
$L_d$	Internal drain inductance	Measured from drain lead to centre of die	-	4.5	-	nH
$L_s$	Internal source inductance	Measured from source lead to source bond pad	-	7.5	-	nH
$C_{iss}$	Input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 25\text{ V}; f = 1\text{ MHz}$	-	610	-	pF
$C_{oss}$	Output capacitance		-	96	-	pF
$C_{rss}$	Feedback capacitance		-	54	-	pF

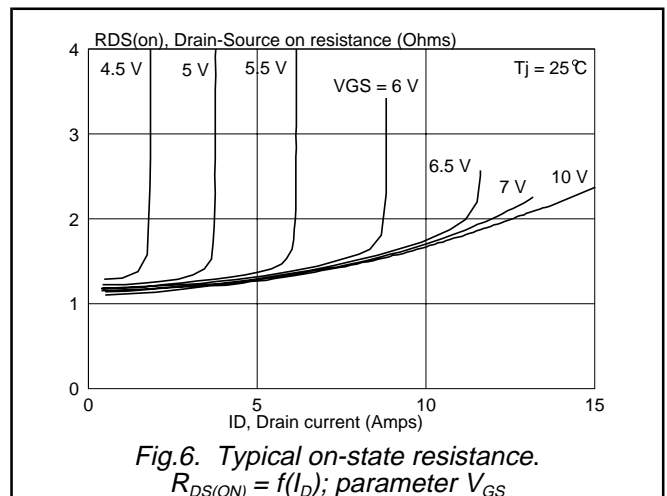
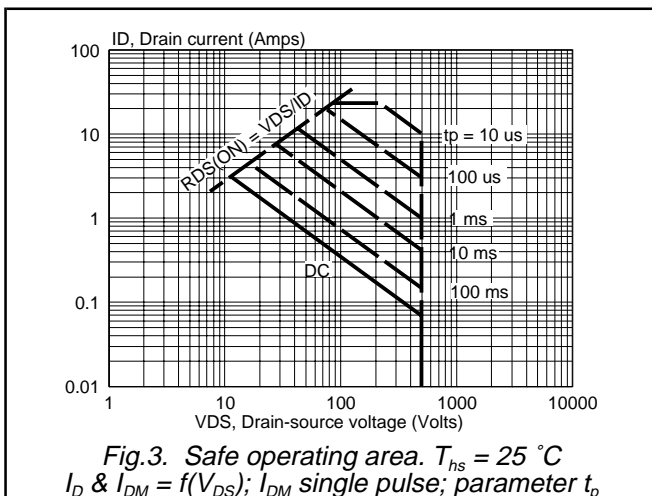
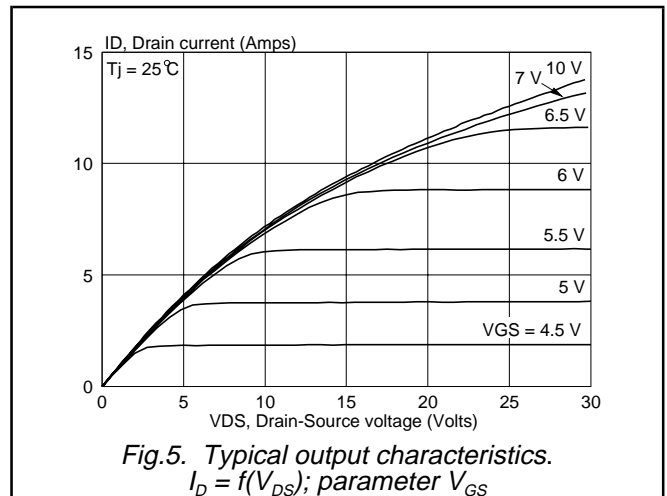
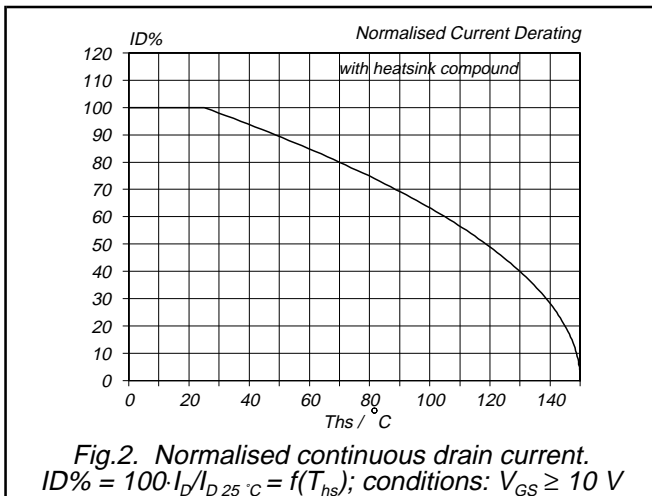
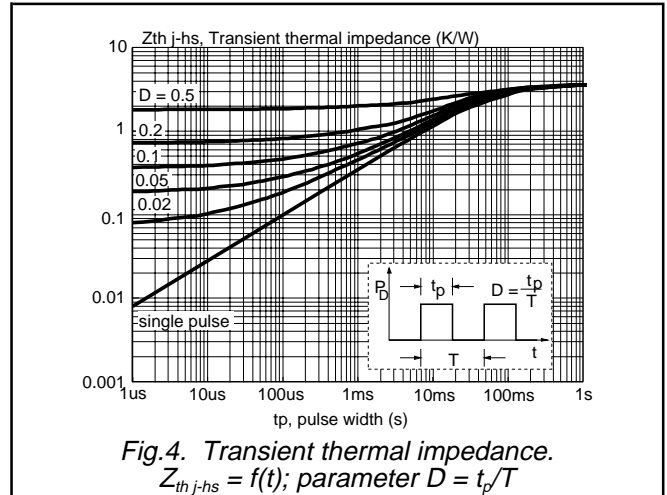
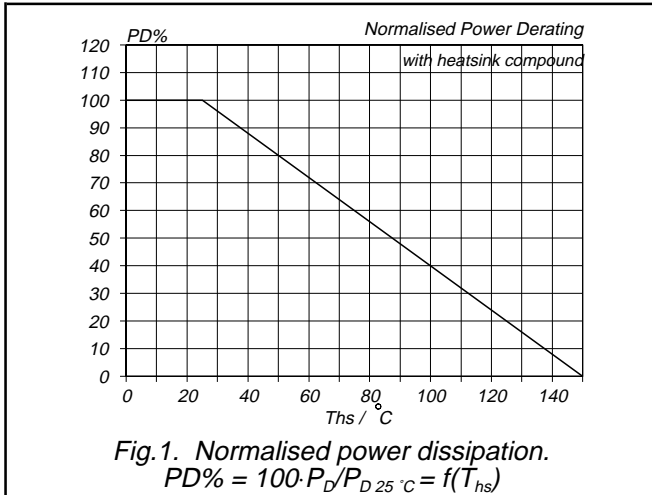
### SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

$T_j = 25\text{ °C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_S$	Continuous source current (body diode)	$T_{hs} = 25\text{ °C}$	-	-	5.9	A
$I_{SM}$	Pulsed source current (body diode)	$T_{hs} = 25\text{ °C}$	-	-	24	A
$V_{SD}$	Diode forward voltage	$I_S = 6\text{ A}; V_{GS} = 0\text{ V}$	-	-	1.5	V
$t_{rr}$	Reverse recovery time	$I_S = 6\text{ A}; V_{GS} = 0\text{ V}; dl/dt = 100\text{ A}/\mu\text{s}$	-	180	-	ns
		$I_S = 6\text{ A}; V_{GS} = 0\text{ V}; dl/dt = 100\text{ A}/\mu\text{s}; 125\text{ °C}$	-	220	-	ns
$Q_{rr}$	Reverse recovery charge	$I_S = 6\text{ A}; V_{GS} = 0\text{ V}; dl/dt = 100\text{ A}/\mu\text{s}$	-	0.65	-	$\mu\text{C}$
		$I_S = 6\text{ A}; V_{GS} = 0\text{ V}; dl/dt = 100\text{ A}/\mu\text{s}; 125\text{ °C}$	-	2.6	-	$\mu\text{C}$
$I_{rrm}$	Peak reverse recovery current	$I_S = 6\text{ A}; V_{GS} = 0\text{ V}; dl/dt = 100\text{ A}/\mu\text{s}; 125\text{ °C}$	-	15	-	A

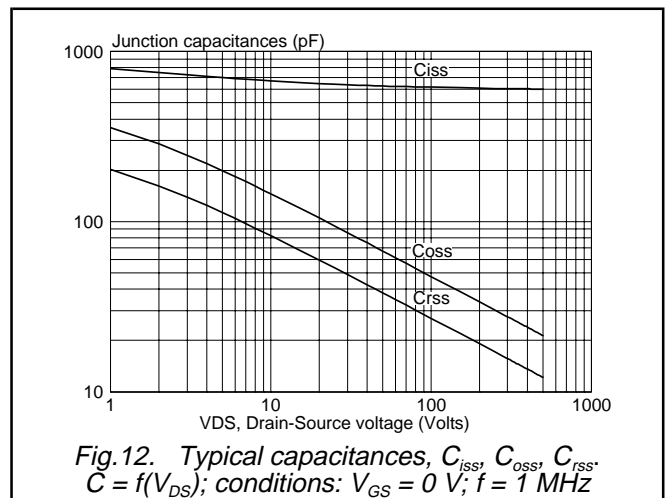
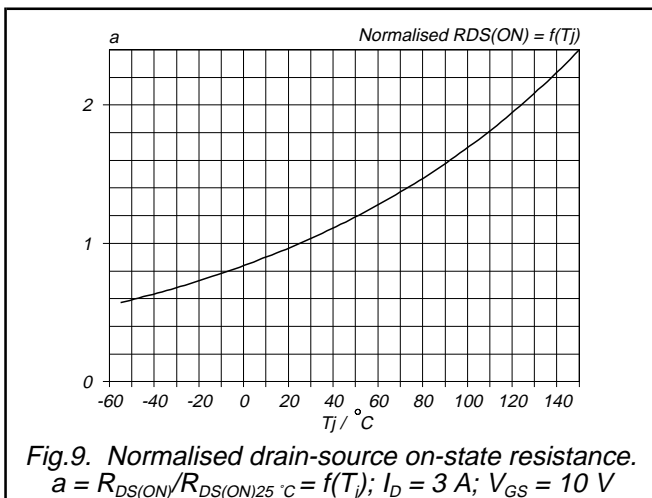
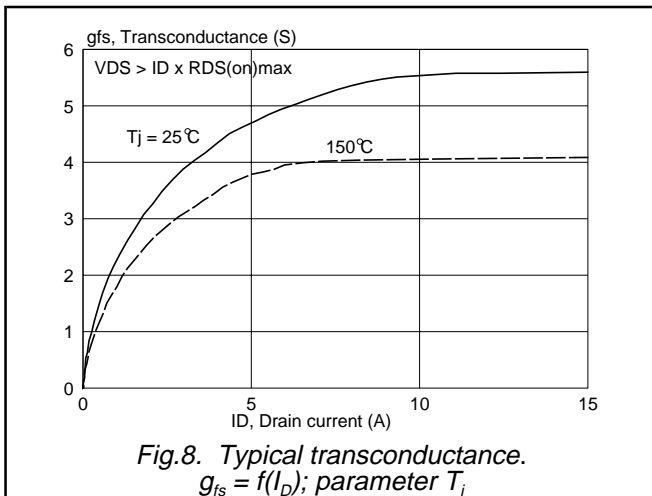
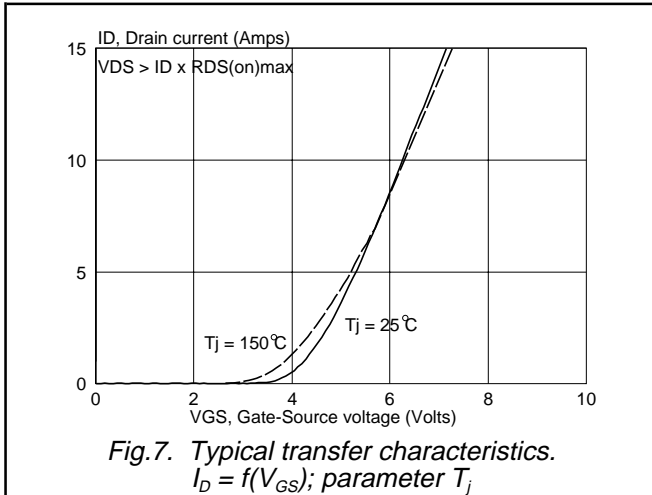
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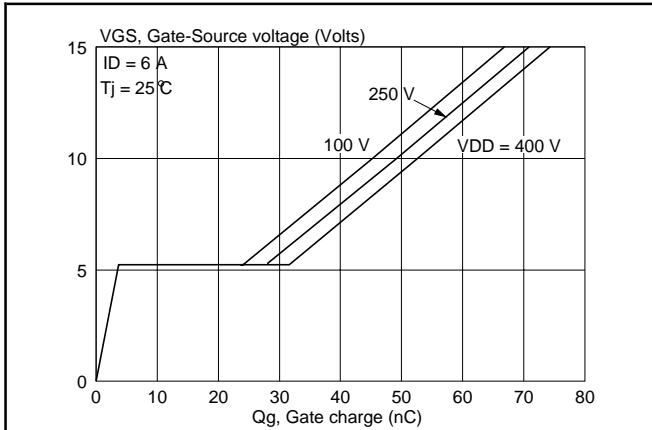


Fig. 13. Typical turn-on gate-charge characteristics.  
 $V_{GS} = f(Q_G)$ ; parameter  $V_{DS}$

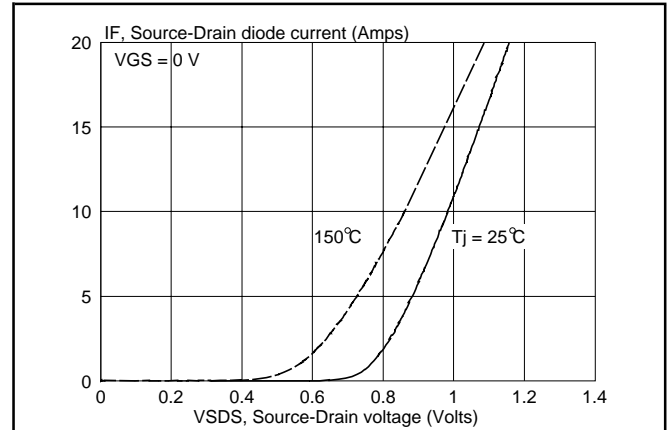


Fig. 16. Source-Drain diode characteristic.  
 $I_F = f(V_{SDS})$ ; parameter  $T_j$

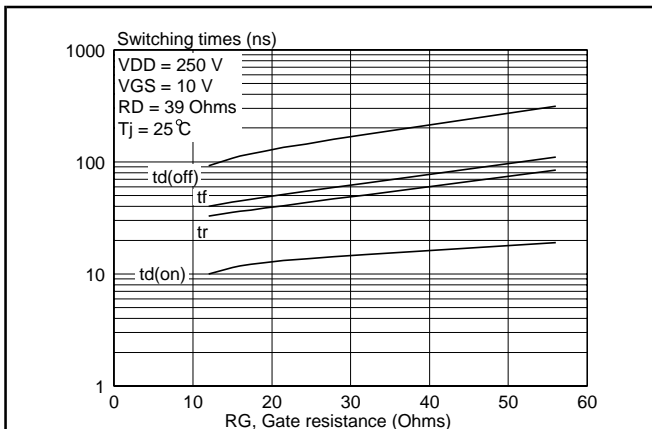


Fig. 14. Typical switching times;  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f = f(R_G)$

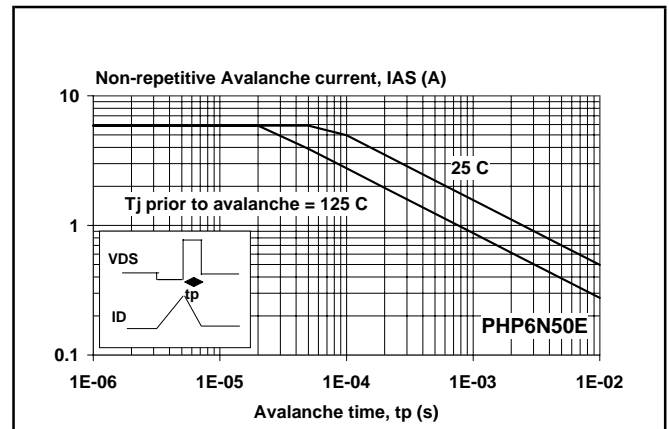


Fig. 17. Maximum permissible non-repetitive avalanche current ( $I_{AS}$ ) versus avalanche time ( $t_p$ ); unclamped inductive load

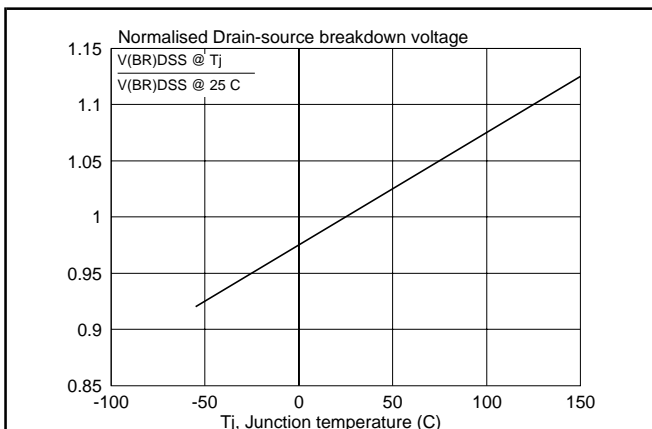


Fig. 15. Normalised drain-source breakdown voltage;  
 $V_{(BR)DSS} / V_{(BR)DSS 25^\circ C} = f(T_j)$

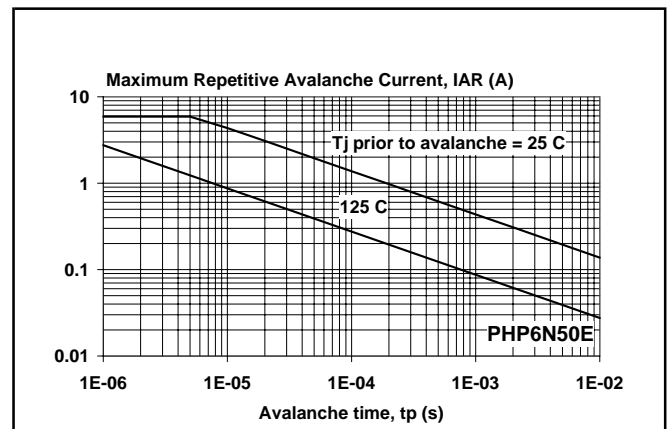
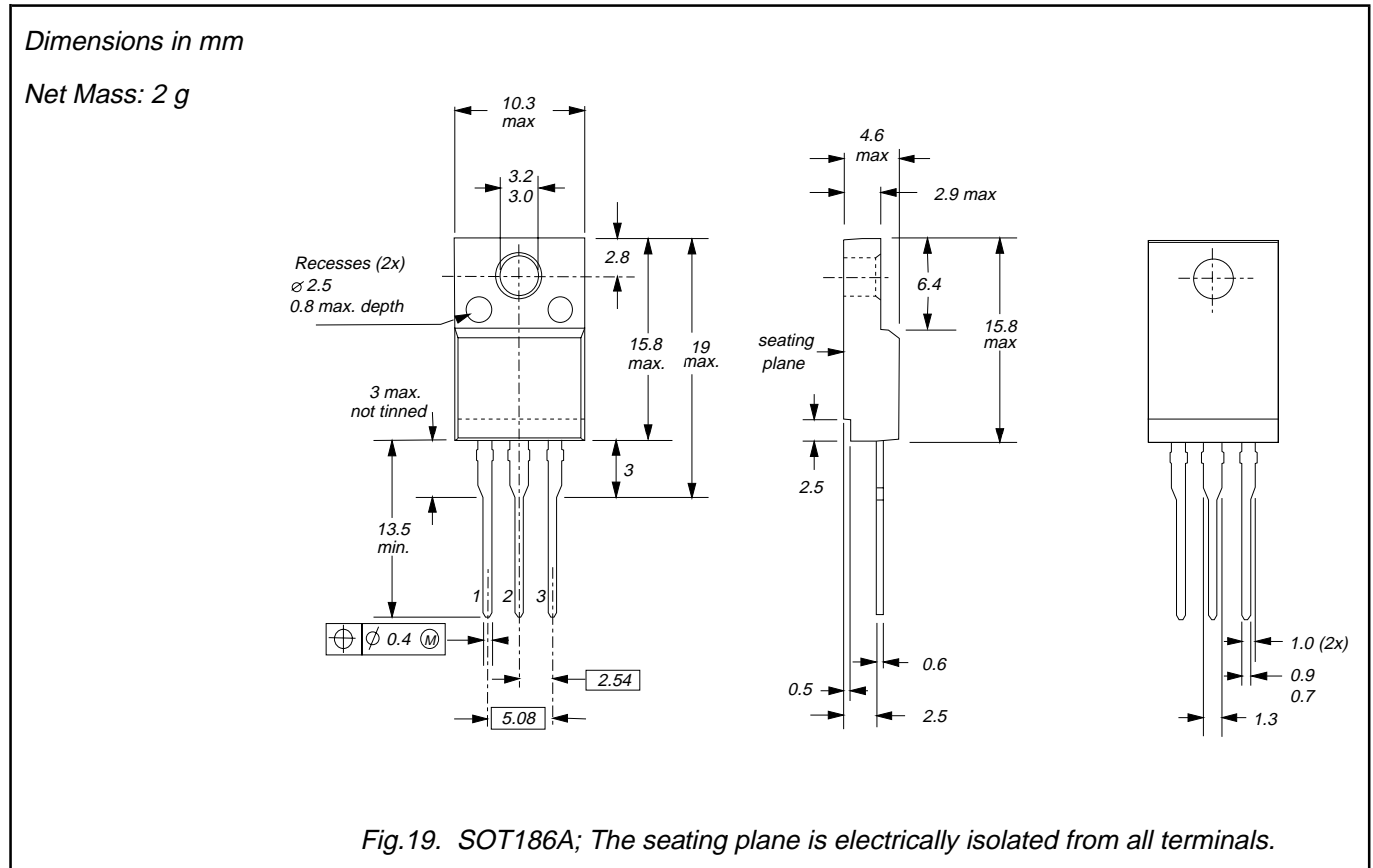


Fig. 18. Maximum permissible repetitive avalanche current ( $I_{AR}$ ) versus avalanche time ( $t_p$ )

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**MECHANICAL DATA**



**Notes**

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for F-pack envelopes.
3. Epoxy meets UL94 V0 at 1/8".

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**DEFINITIONS**

<b>Data sheet status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	
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